

## LH0032/LH0032C

### Ultra Fast FET-Input Operational Amplifier

#### FEATURES

- 500V/ $\mu$ s Slew Rate
- 70MHz Bandwidth
- $10^{12}\Omega$  Input Impedance
- As Low as 2mV Max Input Offset Voltage
- FET Input
- Offset Null with Single Pot
- No Compensation for Gains above 50
- Peak Output Current to 100mA

#### PRODUCT DESCRIPTION

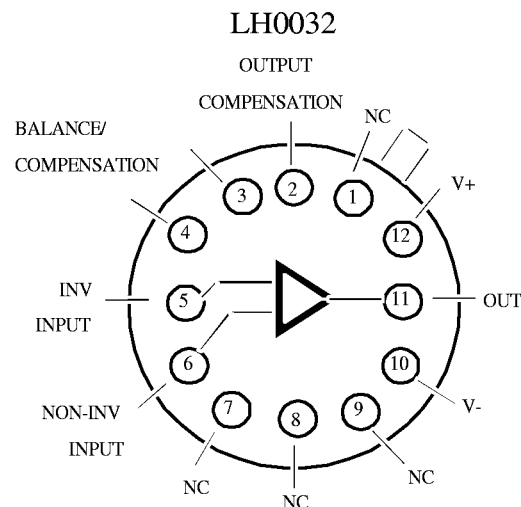
The ALPHA Semiconductor LH0032 is a FET input, high slew rate amplifier capable of driving up to 100mA current.

With wide bandwidth, high slew rate, high input impedance and high current drive capability, LH0032 is an ideal choice for many applications that includes high speed integrator, video amplifier, summing amplifier, high speed D/A converters, etc.

#### ORDERING INFORMATION

PART #	PACKAGE TYPE	TEMPERATURE RANGE
LH0032G	H12A (T08-12 Lead)	-55°C to +125°C
LH0032CG	H12A (T08-12 Lead)	-25°C to +85°C

#### PIN CONNECTIONS



## ABSOLUTE MAXIMUM RATINGS

Supply Voltage, $V_S$ .....	$\pm 18V$
Input Voltage, $V_{IN}$ .....	$\pm V_S$
Input Voltage..... (Equal to Power Supply Voltage)	
Differential Input Voltage.....	$\pm 30V$ or $\pm 2V_S$
Power Dissipation $P_D$	
$T_A = 25^\circ C$ .....	1.5W, derate 100°C/W to 125°C
$T_C = 25^\circ C$ .....	2.2W, derate 70°C/W to 125°C

Operating Temperature Range, $T_A$	
LH0032G .....	-55°C to +125°C
LH0032CG .....	-25°C to +85°C
Operating Junction Temperature, $T_J$ .....	175°C
Storage Temperature Range .....	-65°C to +150°C
Lead Temp. (Soldering, 10 seconds).....	300°C

## DC ELECTRICAL CHARACTERISTICS:

$V_S = \pm 15V$ ,  $T_{MIN} \leq T_A \leq T_{MAX}$  unless otherwise noted (Note 1) ( $T_A = T_J$ )

Parameter	Conditions	LH0032			LH0032C			Units
		Min	Typ	Max	Min	Typ	Max	
Input Offset Voltage	$T_A = T_J = 25^\circ C$ (Note 3)		2	5 10		2	15 20	mV
Average Offset Voltage Drift	(Note 4)		15	50		15	50	$\mu V/^\circ C$
Input Offset Current	$T_J = 25^\circ C$ (Note 2) $T_A = 25^\circ C$ (Note 3)			25 250 25			50 500 5	pA pA nA
Input Bias Current	$T_J = 25^\circ C$ (Note 2) $T_A = 25^\circ C$ (Note 3)			100 1 50	0.96	0.98	500 5 15	pA nA nA
Input Voltage Range	Note 6	$\pm 10$	$\pm 12$		$\pm 10$	$\pm 12$		V
Common Mode Rejection Ratio	$\Delta V_{IN} = \pm 10V$	50	60		50	60		dB
Open-Loop Voltage Gain	$V_O = \pm 10V$ $T_J = 25^\circ C$ $f = 1kHz$ $R_L = 1k\Omega$ (Note 7)	60 57	70		60 57	70		dB
Output Voltage Swing	$R_L = 1k\Omega$	$\pm 10$	$\pm 13$		$\pm 10$	$\pm 13$		V
Power Supply Current	$T_A = 25^\circ C$ $I_O = 0$ (Note 3)		18	20		20	22	mA
Power Supply Rejection Ratio	$\Delta V_S = 10V$ ( $\pm 5$ to $\pm 15V$ )	50	60		50	60		dB

## AC ELECTRICAL CHARACTERISTICS:

$V_S = \pm 15V$ ,  $R_L = 1k\Omega$ ,  $T_J = 25^\circ C$  (Note 5)

Parameter	Conditions	Min	Typ.	Max	Units
Slew Rate	$A_V = +1$	350	500		V/ $\mu s$
Setting Time to 1% of Final Value	$A_V = -1$ $\Delta V_{IN} = 20V$		100		
Setting Time to 0.1% of Final Value	$A_V = -1$ $\Delta V_{IN} = 20V$		300		ns
Small Signal Rise Time	$A_V = +1$ , $\Delta V_{IN} = 1V$		8	20	
Small Signal Delay Time	$A_V = +1$ , $\Delta V_{IN} = 1V$		10	25	

Note 1: LH0032G/CG are a 100% production tested as specified at 25°C. Specifications at temperature extremes are verified by testing, periodic characterization, or correlation.

Note 2: Specification is at 25°C junction temperature due to requirements of high speed automatic testing. Actual values at operating temperature will exceed the value at  $T_J = 25^\circ C$ . When supply voltages are  $\pm 15V$ , no load-operating junction temperature may rise 40-60°C above ambient, and more under load conditions. Accordingly,  $V_{OS}$  may change one to several mV, and  $I_B$  and  $I_{OS}$  will change significantly during warm-up. Refer to  $I_B$  and  $I_{OS}$  vs. Temperature graph for expected values.

Note 3: Measured in still air 7 minutes after application of power. Guaranteed through correlated automatic pulse testing.

Note 4:  $\Delta V_{OS}/\Delta T$  is the average value calculated from measurements at 25°C and  $T_{MAX}$ , specifications at temperature are verified by testing, periodic characterization, or correlation.

Note 5: Not 100% production tested; verified by testing, periodic characterization, or correlation.

Note 6: Guaranteed by CMRR test condition.

Note 7: Guaranteed through correlated pulse testing at  $T_J = 25^\circ C$ .